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U.S. UTILITY Patent Application

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APPLICATION NO.	CONT/PRIOR	CLASS	SUBCLASS	ART UNIT	EXAMINER .
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Elia Mouchawar Bonian Dai Mohssen Fard Gregory Hauck

Method and apparatus for electrophysiological testing in an implantable device, $\boldsymbol{\gamma}_{i}$

ISSUING CLASSIFICATION

ORIGINAL CROSS REFERENCE(S)

CLASS SUBCLASS CLASS SUBCLASS (ONE SUBCLASS PER BLOCK)

INTERNATIONAL CLASSIFICATION

Continued on Issue Slip Inside File Jacket

TERMINAL	DRAWINGS		CLAIMS ALLOWED		
L.J DISCLAIMER	Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims	Print Claim for O.G.
☐ The term of this patent	(Assistant Examiner)		٠.	NOTICE OF ALLOWANCE MAILED	
subsequent to (date) has been disclaimed.			(Date)	·	
The term of this patent shall					·
not extend beyond the expiration date of U.S Patent. No.			ISSUE FEE		
				Amount Due	Date Paid
	(Primary Examiner)		(Date)	•	
☐ The terminalmonths of this patent have been disclaimed.				ISSUE BATCH NUMBER	
	(Legal Instruments Examiner)		(Date)		
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orm PTO-436A Rev. 6/99)			FILED WITH:	DISK (CRF)	FICHE CD-ROI

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